

# **60V N-Channel DTMOS**

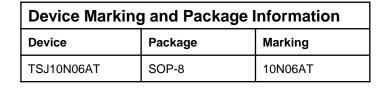
#### **FEATURES**

- Trench Power DTMOS technology
- Low R<sub>DS(ON)</sub>
- Low Gate Charge
- Optimized for fast-switching applications

#### **APPLICATIONS**

- Synchronous Rectification in DC/DC and AC/DC Converters
- Isolated DC/DC Converters in Telecom and Industrial

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<b>Absolute Maximum Ratings</b> $T_C = 25^{\circ}C$ , unless otherwise noted			
Parameter	Symbol	Value	Unit
Drain-Source Voltage (V <sub>GS</sub> = 0V)	V <sub>DSS</sub>	60	V
Continuous Drain Current	I <sub>D</sub>	10	Α
Pulsed Drain Current (note1)	I <sub>DM</sub>	40	Α
Gate-Source Voltage	V <sub>GSS</sub>	±20	V
Single Pulse Avalanche Energy (note2)	E <sub>AS</sub>	20	mJ
Avalanche Current (note1)	I <sub>AS</sub>	20	Α
Power Dissipation (T <sub>C</sub> = 25°C)	P <sub>D</sub>	3.1	W
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55~+150	°C

Thermal Resistance			
Parameter	Symbol	Value	Unit
Junction-to-Drain Lead	R <sub>thJC</sub>	24	000
Thermal Resistance, Junction-to-Ambient	R <sub>thJA</sub>	40	°C/W



<b>Decifications</b> T <sub>J</sub> = 25°C, unless otherwise noted							
Parameter	Symbol	Test Conditions	Value			Unit	
			Min.	Тур.	Max.		
Static			1				
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_{D} = 250\mu A$	60			V	
Zara Cata Valtaria Dissis Ossis at	١,	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 25^{\circ}C$			1	μA	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 60V, V_{GS} = 0V, T_{J} = 150^{\circ}C$			100	μΑ.	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20V$			±100	nA	
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.1		2.5	V	
	D	$V_{GS} = 10V, I_D = 10A$		12	15	0	
Drain-Source On-Resistance (Note3)	R <sub>DS(on)</sub>	$V_{GS} = 4.5V, I_{D} = 9A$		15	19	mΩ	
Forward Transconductance (Note3)	g <sub>fs</sub>	$V_{DS} = 5V, I_{D} = 10A$		35		S	
Dynamic				•			
Input Capacitance	C <sub>iss</sub>	V 0V		1134		pF	
Output Capacitance	C <sub>oss</sub>	$V_{GS} = 0V,$ $V_{DS} = 30V,$		123			
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0MHz		12			
T	Q <sub>g</sub> (10V)			21		nC	
Total Gate Charge	Q <sub>g</sub> (4.5V)	$V_{DD} = 30V, I_{D} = 10A,$		11			
Gate-Source Charge	$Q_{gs}$	$V_{GS} = 10V$		3.1			
Gate-Drain Charge	$Q_{gd}$			5.1			
Turn-on Delay Time	t <sub>d(on)</sub>			7			
Turn-on Rise Time	t <sub>r</sub>	$V_{DD} = 30V, I_{D} = 10A,$		3			
Turn-off Delay Time	t <sub>d(off)</sub>	$R_G = 3\Omega$		20		ns	
Turn-off Fall Time	t <sub>f</sub>			3			
Drain-Source Body Diode Characteri	stics		<u>I</u>	!	!		
Continuous Body Diode Current	I <sub>S</sub>				4		
Pulsed Diode Forward Current	I <sub>SM</sub>	$T_{\rm C} = 25^{\rm o}{\rm C}$			12	Α	
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25^{\circ}C$ , $I_{SD} = 1A$ , $V_{GS} = 0V$		0.72	1	V	
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 10A,		17		ns	
Reverse Recovery Charge	Q <sub>rr</sub>	$di_{F}/dt = 500A/\mu s$		60		nC	

#### Notes

- 1. Repetitive Rating: Pulse Width limited by maximum junction temperature
- 2.  $I_{AS}$  = 20A,  $V_{DD}$  = 50V,  $R_{G}$  = 25 $\Omega$ , Starting  $T_{J}$  = 25 $^{\circ}$ C
- 3. Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 1%
- 4. When mounted on 1" in square copper board



## **Typical Characteristics** $T_J = 25^{\circ}C$ , unless otherwise noted

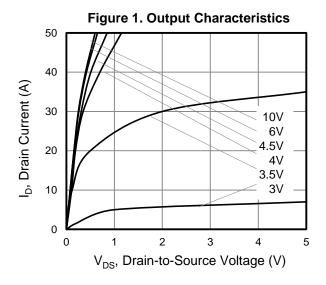


Figure 3. On-Resistance vs. Drain Current

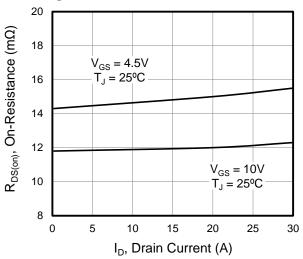


Figure 5. Gate Charge

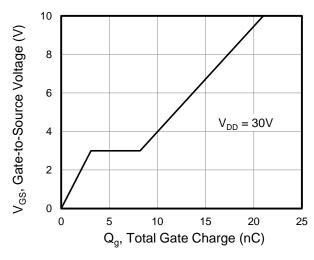


Figure 2. Transfer Characteristics

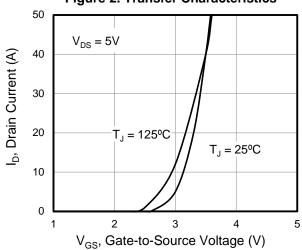


Figure 4. Capacitance

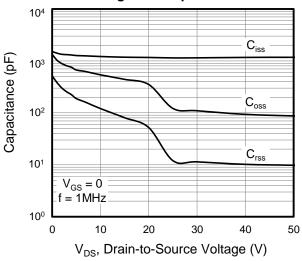
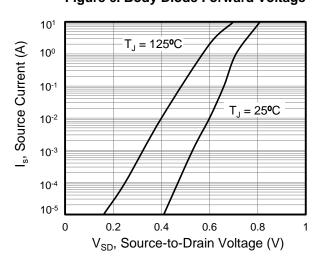


Figure 6. Body Diode Forward Voltage



## **Typical Characteristics** $T_J = 25^{\circ}\text{C}$ , unless otherwise noted

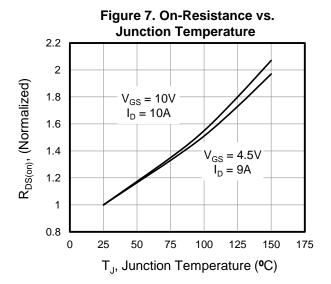


Figure 8. Threshold Voltage vs. Junction Temperature 1.2 1.1 V<sub>GS(th)</sub>, (Variance)  $I_{D} = 250 \mu A$ 1 0.9 8.0 0.7 0.6 50 -100 -50 0 100 150 200 T<sub>J</sub>, Junction Temperature (°C)

Figure 9. Transient Thermal Impedance

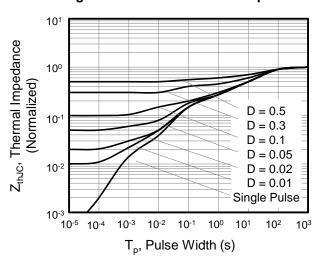


Figure A: Gate Charge Test Circuit and Waveform

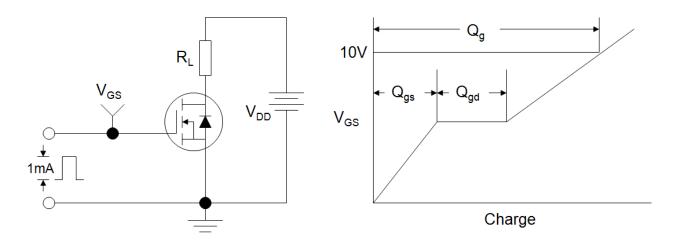


Figure B: Resistive Switching Test Circuit and Waveform

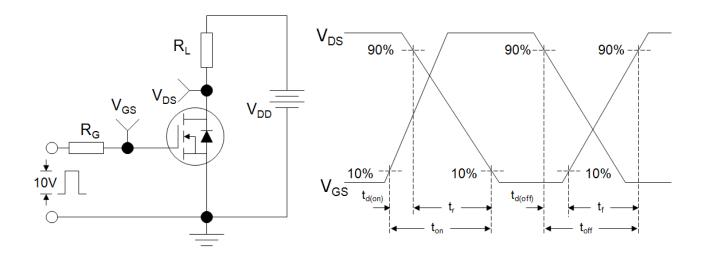
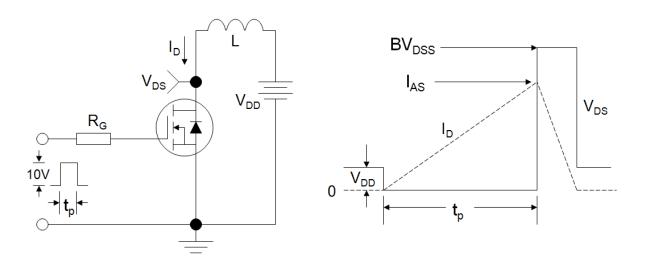
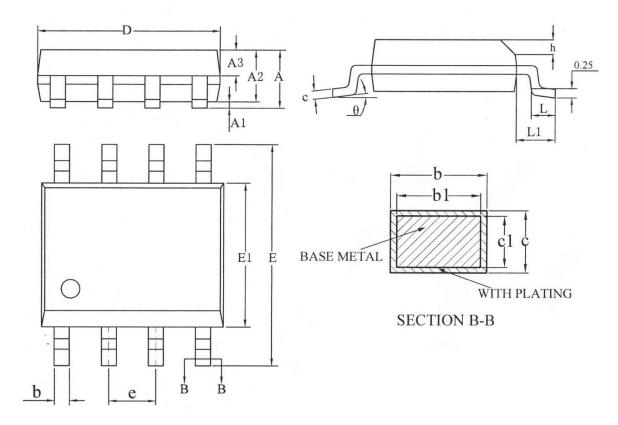


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





# SOP-8



SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
A		_	1.75	
A1	0.10		0.225	
A2	1.30	1.40	1.50	
A3	0.60	0.65	0.70	
b	0.39	_	0.48	
b1	0.38	0.41	0.43	
С	0.21	_	0.26	
c1	0.19	0.20	0.21	

SYMBOL	MILLIMETER			
	MIN	NOM	MAX	
D	4.70	4.90	5.10	
Е	5.80	6.00	6.20	
E1	3.70	3.90	4.10	
e	1.27BSC			
h	0.25	_	0.50	
L	0.50		0.80	
L1	1.05BSC			
θ	0	_	8°	



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